

## **SiPM timing measurements at LAL**

### XII SuperB Workshop Frascati, September 27-31 2010

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2010 Sept 27-31 V. Puill, XIIth SuperB Project Meeting, Frascati,

### SiPMs (1 mm<sup>2</sup>) measured at LAL

I.



	Reference	Pixel nb	Pixel size (µm)	Fill factor (%)
F.B.K B	B11 B13	400 400	50 x 50 50 x 50	
Hamamatsu MPPC	S10362-11-25	1600	25 x 25	31
	S10362-11-50	400	50 x 50	61.6
	S10362-11-100	100	100 x 100	78.5
	10-50S-BK 4S	400	50 x 50	38
	10-100S-FS	100	100 x 100	78
SensL SPM		T		r
	SPM-20	848	29 x 32	43
	SPM-50	216	59x 62	68

### Determination of the operational voltage range of the SiPMs





### Evolution of Ireverse with the bias voltage





### Measurement of the gain and $V_{BD}$ (breakdown voltage)









Breakdown voltage increases with the temperature

 $dV_{BD}/dT \sim 59 \text{ mV/}^{\circ}\text{C}$  for the MPPC 10-100 S-FS

Correction of the bias voltage if the temperature changes inside the test bench to maintain a constant gain

### Measurement of the Dark Count Rate

Dark noise : thermally produced avalanches. Look the same as pulses from photon



#### DCR MPPC 10-100 S-FS-n°11

ΔV (V)



### Optical test bench for the TTS measurements





### Contribution to the timing resolution of the detection chain

#### Pilas pulsed laser diode



🐥 Pilas driver : jitter ≈ 3 ps

- Timing resolution of the LECROY scope = 1 ps
- Timing resolution of the Wavecatcher = 8 ps
- Timing resolution of the SiPM ?

### SiPMs signals (voltage amplifier output)

HAMAMATSU MPPC S10362-11



HAMAMATSU MPPC 50 µm (2009)





FBK SiPM (ref B) (2009)



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### Measurement principle of the SiPM timing resolution





Measurement of the time between the laser and the SiPM signals  $\rightarrow$  distribution of the  $\Delta t$ 

### $\Delta t$ and amplitude distribution of the SiPM signals



#### MPPC-1-100-n3-70.0V

#### MPPC-1-100-n3-69.3V





### Cross-talk definition



### Noise : pulses triggered by non-photo-generated carriers



An avalanche in one pixel may produce an optical photon wich can trigger another avalanche in a neighboring pixel without delay

2010

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### Contribution of the cross-talk to the TTS histo tail





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Data from Wavecatcher

### Single Photo Electron Timing Resolution





### Single Photo Electron Timing Resolution



FBK and Sensl devices

T = 20 °C, λ = 467 nm



### Conclusion, further work

#### **Conclusion**

- 65 ps < SPTR SiPM 1 mm<sup>2</sup>< 85 ps at 20 °C, 467 nm
- SPTR measurements with the Wavecatcher and the LECROY scope in agreement (15 %)
- Tail of the TTS histo  $\rightarrow$  to be undersood

#### **Further work**

★ Measurement of the SiPM timing resolution of 9 mm<sup>2</sup> SiPM (HAMAMATSU, FBK, Sensl)

 $\star$  Measurement of the SiPM timing resolution in function of the :

- ✤ wavelength (403 nm and 633 nm)
- simultaneous incident number of photons
- ✤ temperature

**★** Study of Burle (64 anodes) and HAMAMATSU (SL10 4 and 16 anodes) MCP-PMTs

# Additional slides

T = 20°C	type détecteur	Vbd (V)	V1 (V)	V2 (V)	V3 (V)
HPK	MPPC 10-50S-BK 4S n°10	69,1	70,1	70,9	71,5
DCR (Hz)	MPPC 10-50S-BK 4S n°10		2,91E+05	6,45E+05	1,18E+06
Gain th	MPPC 10-50S-BK 4S n°10		4,17E+05	7,56E+05	1,00E+06
HPK	MPPC 10-100S-FS n°11	69,12	69,5	70	70,5
DCR (Hz)	MPPC 10-100S-FS n°11		2,00E+05	4,00E+05	6,00E+05
Gain th	MPPC 10-100S-FS n°11		7,85E+05	1,85E+06	2,88E+06
HPK	S10362-11-025U-n°11	68,2	69,2	70,2	71,2
DCR (Hz)	S10362-11-025U-n°11		4,30E+04	1,08E+05	1,90E+05
Gain th	S10362-11-025U-n°11		1,28E+05	2,50E+05	3,74E+05
HPK	S10362-11-050U-n°3	68,35	69,2	69,8	70,4
DCR (Hz)	S10362-11-050U-n°3		1,53E+05	2,94E+05	4,81E+05
Gain th	S10362-11-050U-n°3		5,41E+05	9,24E+05	1,31E+06
HPK	S10362-11-100U-n°3	68,71	69,5	70	
DCR (Hz)	S10362-11-100U-n°3		1,76E+05	5,28E+05	
Gain th	S10362-11-100U-n°3		2,10E+06	3,36E+06	
FBK	FBK IRST B13	29,4	29,9	30,5	31,1
DCR (Hz)	FBK IRST B13			3,45E+06	5,87E+06
Gain th	FBK IRST B13		2,36E+05	5,19E+05	8,03E+05
				20.4	
FBK	FBK IRST BII	28,8	30	30,4	
DCR (Hz)	FBK IRST BII		2,95E+06	4,04E+06	
Gain th	FBK IRST BIT		5,27E+05	7,18E+05	
OFNOI	Sanal 200	20.00	20	20 5	01
	Sensi 20µ	29,02	30 7 005±05	30,3 7 125±05	31 761 <u>₽</u> ±05
$C_{\text{oin th}}$	Senal 20µ		1,09E+05	7,13E+05	2 12E+05
Gain th	Bense 20µ		4,33⊵+05	0,300+05	0,135+03

#### MPPC 50 $\mu$ m « wide trace »

	Quenching resist	ance = $130K\Omega$ by for $\Omega$	brward IV curve
Sample name	STD	Small pixel	Wide trace
Sample name Fill factor	STD 62 %	Small pixel 38 %	Wide trace 38 %
Sample name Fill factor ΔV(Vop−Vbr) #1	62 %	38 % 2.02 V	Wide trace   38 %   2.01 V
Sample name Fill factor ∆V(Vop−Vbr) #1 Dark count at Vop	STD 62 % 1.31 V 535 Kcps	Small pixel   38 %   2.02 V   484 Kcps	Wide trace   38 %   2.01 V   502 Kcps
Sample name Fill factor ∆V(Vop−Vbr) #1 Dark count at Vop Pixel capacitance (Cd) #2	STD 62 % 1.31 V 535 Kcps 90 fF	Small pixel   38 %   2.02 V   484 Kcps   59 fF	Wide trace   38 %   2.01 V   502 Kcps   60 fF
Sample name Fill factor ∆V(Vop−Vbr) #1 Dark count at Vop Pixel capacitance (Cd) #2 Stray capacitance / pixel #3	STD 62 % 1.31 V 535 Kcps 90 fF 2.5 fF	Small pixel   38 %   2.02 V   484 Kcps   59 fF   11 fF	Wide trace   38 %   2.01 V   502 Kcps   60 fF   23 fF

Quenching resistance =  $115K\Omega$  by forward IV curve





Sample name	STD	Small pixel	Wide trace
Fill factor	78 %	72 %	72 %
∆V(Vop—Vbr) #1	1.02 V	1.18 V	1.18 V
Dark count at Vop	1075 Kcps	1089 Kcps	1243 Kcps
Pixel capacitance (Cd) #2	373 fF	323 fF	325 fF
Stray capacitance / pixel #3	17 fF	37 fF	61 fF
PDE at Vop , 440nm	79.7 %	76.2 %	77.6 %

#1 : Vop is at 2.4E06 #2 : by GAIN vs VR curve #3 : Ctotal / 100 - Cd at 25°C

MPPC 100  $\mu m$  « wide trace »